

# Cascadable Silicon Bipolar MMIC Amplifiers

# Technical Data

## MSA-0735, -0736

#### **Features**

- Cascadable 50  $\Omega$  Gain Block
- Low Operating Voltage:  $4.0\,\mathrm{V}$  Typical  $V_d$
- 3 dB Bandwidth: DC to 2.4 GHz
- 13.0 dB Typical Gain at 1.0 GHz
- Unconditionally Stable (k>1)
- Cost Effective Ceramic Microstrip Package

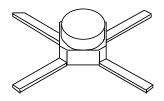
## **Description**

The MSA-0735 is a high performance silicon bipolar Monolithic Microwave Integrated Circuit (MMIC) housed in a cost effective,

microstrip package. This MMIC is designed for use as a general purpose  $50~\Omega$  gain block. Typical applications include narrow and broad band IF and RF amplifiers in industrial  $\,$  and military applications.

The MSA-series is fabricated using HP's 10 GHz f<sub>T</sub>, 25 GHz f<sub>MAX</sub>, silicon bipolar MMIC process which uses nitride self-alignment, ion implantation, and gold metallization to achieve excellent performance, uniformity and reliability. The use of an external bias resistor for temperature and current stability also allows bias flexibility.

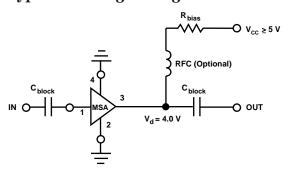
#### 35 micro-X Package<sup>[1]</sup>



#### Note:

1. Short leaded 36 package available upon request.

### **Typical Biasing Configuration**



5965-9591E 6-394

MSA-0735, -0736 Absolute Maximum Ratings

Parameter	Absolute Maximum <sup>[1]</sup>				
Device Current	60 mA				
Power Dissipation <sup>[2,3]</sup>	275 mW				
RF Input Power	+13dBm				
Junction Temperature	200°C				
Storage Temperature	−65 to 200°C				

Thermal Resistance $^{[2,5]}$ :	
$\theta_{\rm jc} = 155$ °C/W	

#### **Notes:**

- 1. Permanent damage may occur if any of these limits are exceeded.
- 2.  $T_{CASE} = 25$ °C.
- 3. Derate at 6.5 mW/°C for  $T_{\rm C} > 157$  °C.
- 4. Storage above  $+150^{\circ}\text{C}$  may tarnish the leads of this package making it difficult to solder into a circuit.
- 5. The small spot size of this technique results in a higher, though more accurate determination of  $\theta_{jc}$  than do alternate methods. See MEASUREMENTS section "Thermal Resistance" for more information.

# Electrical Specifications<sup>[1]</sup>, $T_A = 25^{\circ}C$

Symbol	Parameters and Test Conditions:	Units	Min.	Тур.	Max.	
GP	Power Gain ( $ S_{21} ^2$ )	f = 0.1  GHz	dB	12.5	13.5	14.5
$\Delta G_{ m P}$	Gain Flatness	f = 0.1  to  1.3  GHz	dB		± 0.6	± 1.0
f <sub>3 dB</sub>	3 dB Bandwidth		GHz		2.4	
VCVVD	Input VSWR	f = 0.1  to  2.5  GHz			2.0:1	
VSWR	Output VSWR	f = 0.1  to  2.5  GHz			1.8:1	
NF	$50\Omega$ Noise Figure	f = 1.0  GHz	dB		4.5	
P <sub>1 dB</sub>	Output Power at 1 dB Gain Compression	f = 1.0  GHz	dBm		5.5	
IP <sub>3</sub>	Third Order Intercept Point	f = 1.0  GHz	dBm		19.0	
$t_{\mathrm{D}}$	Group Delay	f = 1.0  GHz	psec		140	
Vd	Device Voltage		V	3.6	4.0	4.4
dV/dT	Device Voltage Temperature Coefficient		mV/°C		-7.0	

#### Note:

## **Part Number Ordering Information**

Part Number	No. of Devices	Container		
MSA-0735	10	Strip		
MSA-0736-BLK	100	Antistatic Bag		
MSA-0736-TR1	1000	7" Reel		

For more information, see "Tape and Reel Packaging for Semiconductor Devices".

<sup>1.</sup> The recommended operating current range for this device is 15 to 40 mA. Typical performance as a function of current is on the following page.

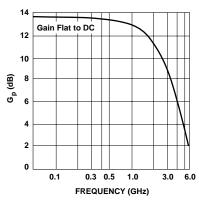
MSA-0735, -0736 Typical Scattering Parameters (Z $_{\rm O}$  = 50  $\Omega,\,T_{\rm A}$  = 25°C,  $I_{\rm d}$  = 22 mA)

Freq.	$S_{11}$		$\mathbf{S}_{21}$		$\mathbf{S_{12}}$			$\mathbf{S}_{22}$		
GHz	Mag	Ang	dB	Mag	Ang	dB	Mag	Ang	Mag	Ang
0.1	.13	<b>-</b> 3	13.5	4.71	175	-19.0	.112	2	.29	<b>-</b> 7
0.2	.13	<b>-</b> 6	13.4	4.69	170	-18.5	.119	3	.29	-12
0.4	.14	-13	13.4	4.68	160	-18.6	.118	6	.29	<b>-</b> 24
0.6	.16	-20	13.3	4.64	150	-18.4	.120	7	.28	<b>-</b> 35
0.8	.19	<b>–</b> 29	13.2	4.60	140	-18.1	.125	8	.28	<b>-4</b> 7
1.0	.21	<b>-4</b> 0	12.9	4.42	129	-17.6	.131	10	.27	-58
1.5	.27	<b>-7</b> 1	12.2	4.07	104	-16.5	.149	10	.24	<b>–</b> 83
2.0	.32	-107	11.5	3.74	79	-15.6	.165	7	.19	-103
2.5	.37	-134	10.3	3.26	62	-15.3	.173	5	.15	<b>-</b> 113
3.0	.43	-160	8.8	2.76	44	-15.4	.171	0	.14	-120
3.5	.47	<b>-179</b>	7.5	2.37	27	-15.3	.173	<del>-4</del>	.16	<b>-</b> 120
4.0	.49	167	6.2	2.05	12	-15.2	.168	<b>-</b> 6	.21	<b>-</b> 121
5.0	.51	134	4.0	1.59	-15	-15.2	.173	-11	.28	<b>-</b> 135
6.0	.60	96	2.1	1.27	<b>-4</b> 2	-14.6	.185	-16	.29	-167

A model for this device is available in the DEVICE MODELS section.

## Typical Performance, $T_A = 25^{\circ}C$

(unless otherwise noted)



 $\begin{array}{l} Figure \ 1. \ Typical \ Power \ Gain \ vs. \\ Frequency, \ I_d = 22 \ mA. \end{array}$ 

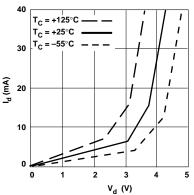


Figure 2. Device Current vs. Voltage.

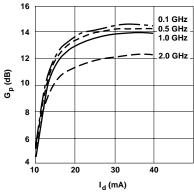


Figure 3. Power Gain vs. Current.

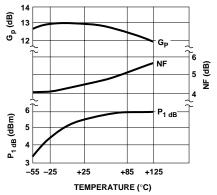


Figure 4. Output Power at 1 dB Gain Compression, NF and Power Gain vs. Case Temperature,  $f=1.0~\mathrm{GHz},$   $I_d=22\mathrm{mA}.$ 

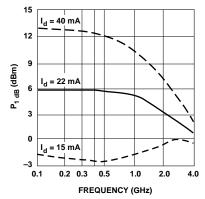


Figure 5. Output Power at 1 dB Gain Compression vs. Frequency.

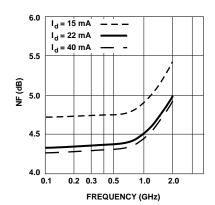


Figure 6. Noise Figure vs. Frequency.

# 35 micro-X Package Dimensions

